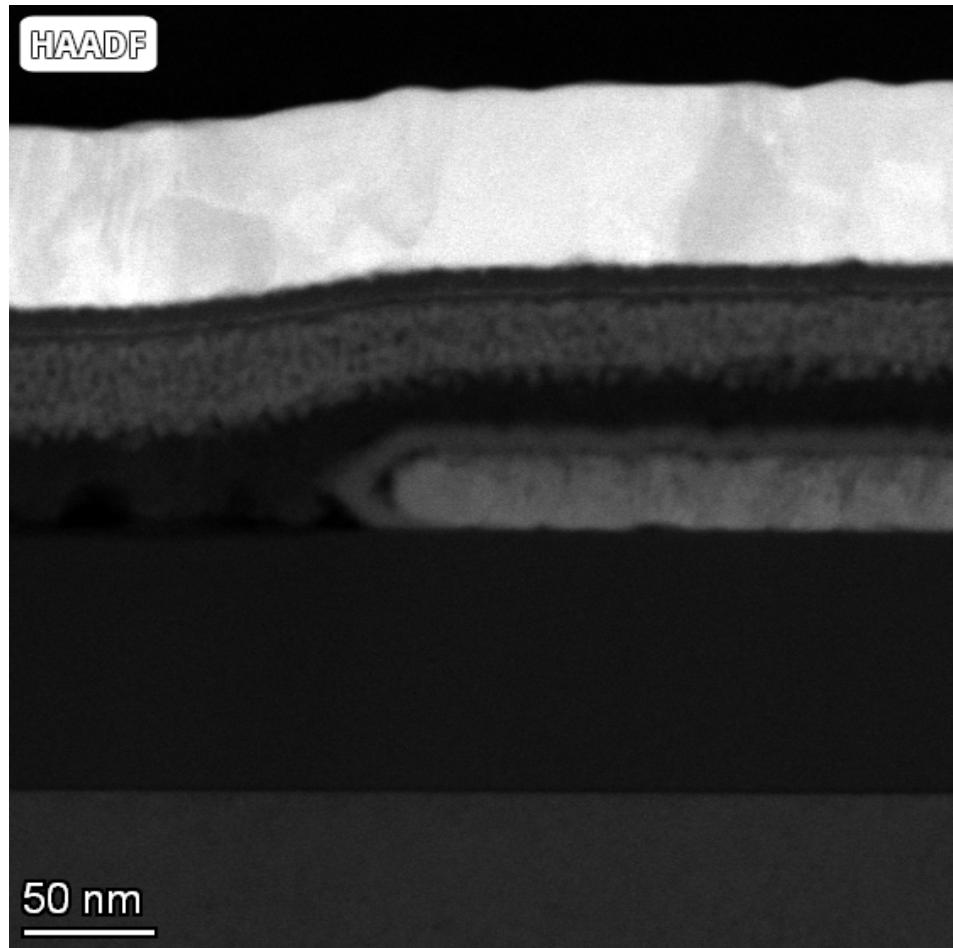


Analytical TEM part I

Duncan Alexander
EPFL-IPHYS-LSME

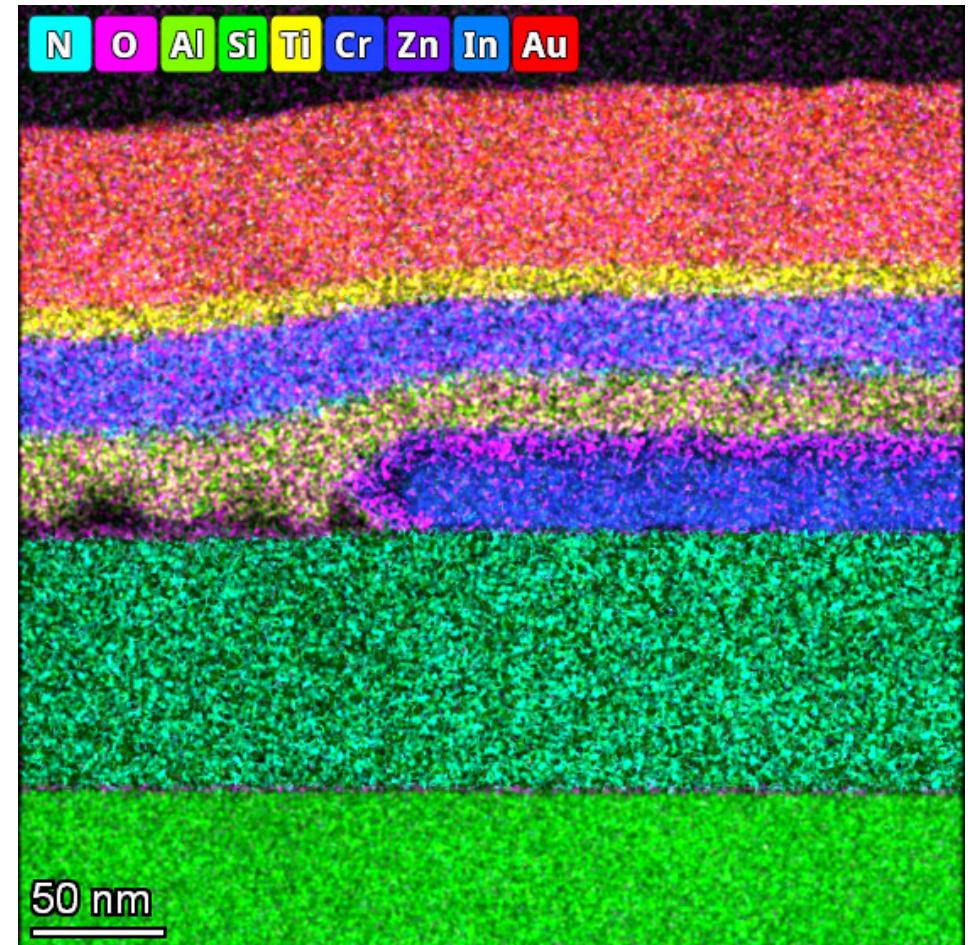
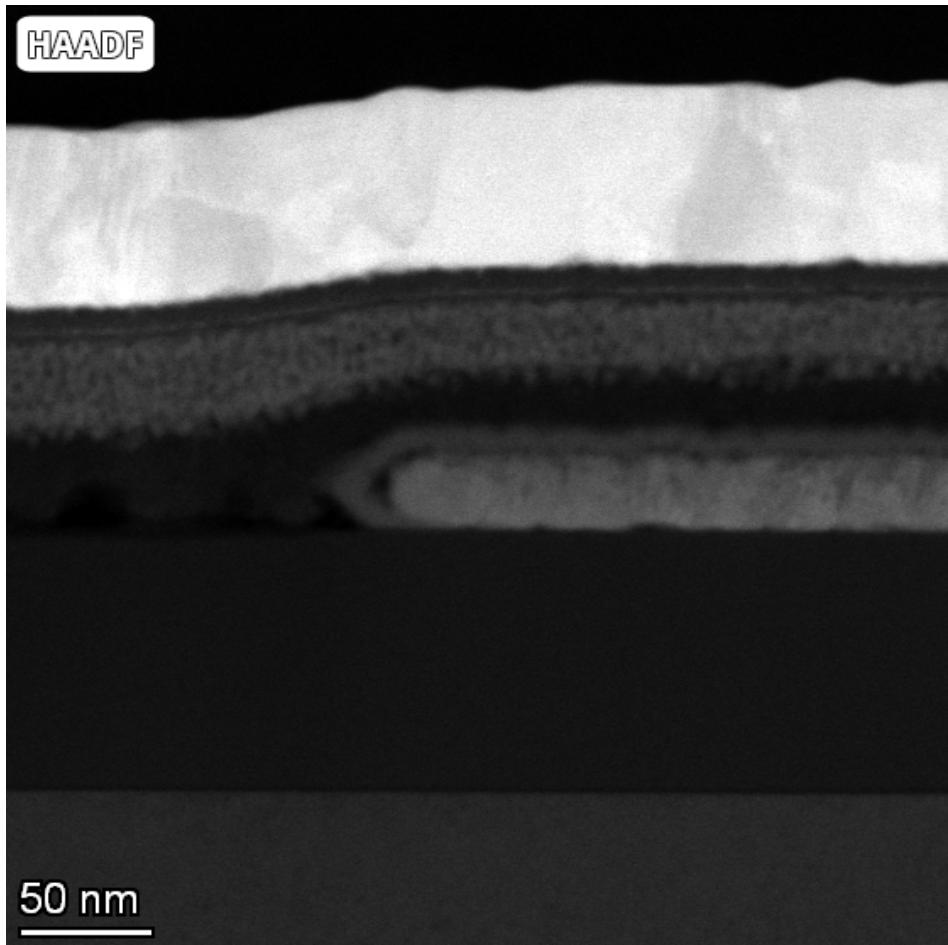
EPFL Adding colour to microscopy!

- Multilayer from first STEM lecture



EPFL Adding colour to microscopy!

- Multilayer from first STEM lecture



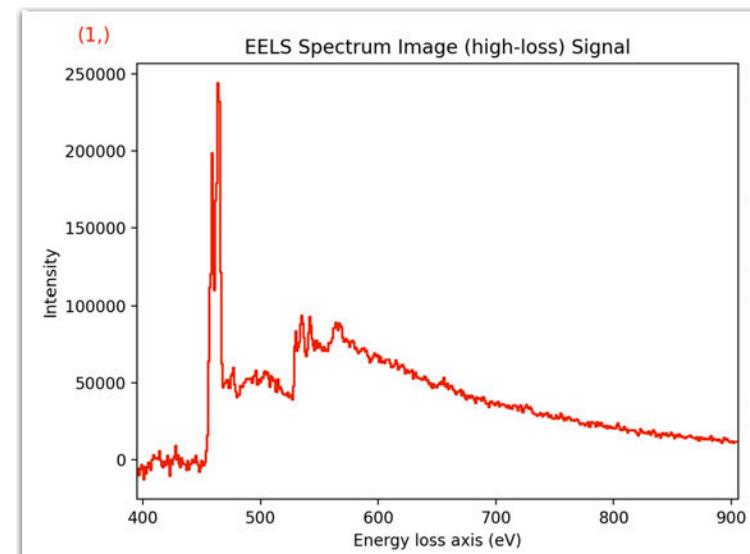
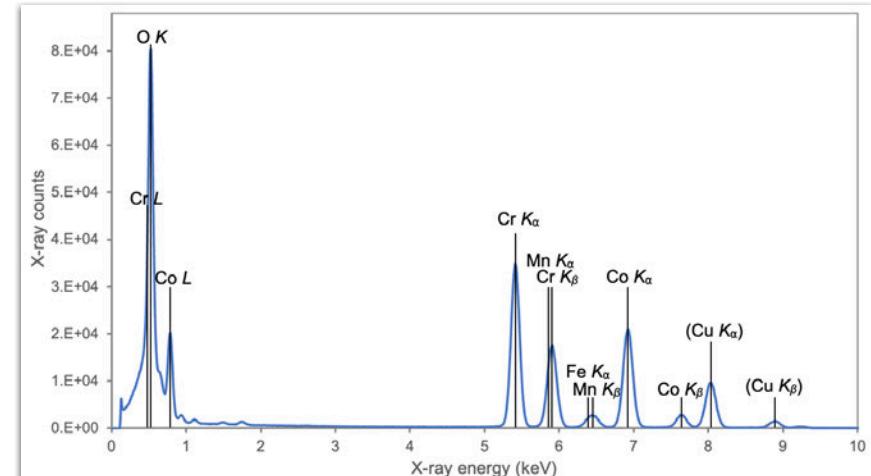
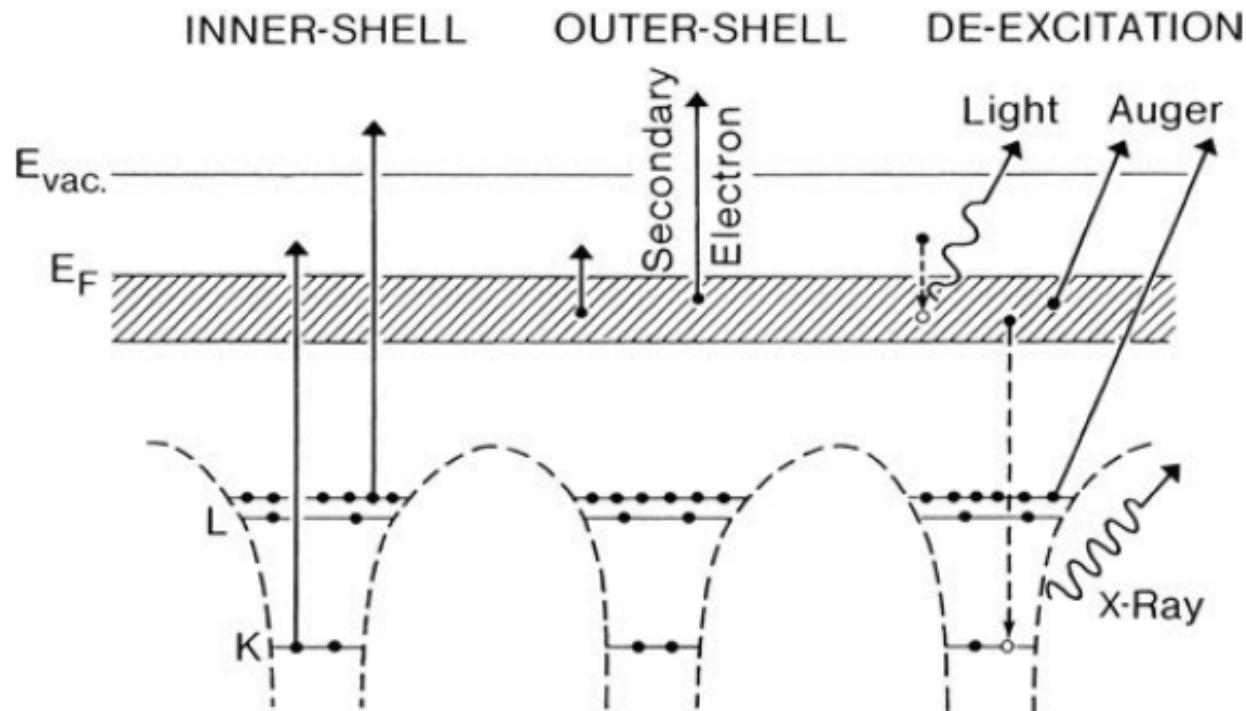
EPFL Contents

- Introduction to EDX spectroscopy and EELS
- Energy dispersive X-ray (EDX) spectroscopy
 - X-ray generation
 - EDX spectrum
 - Detector setup
 - Applications

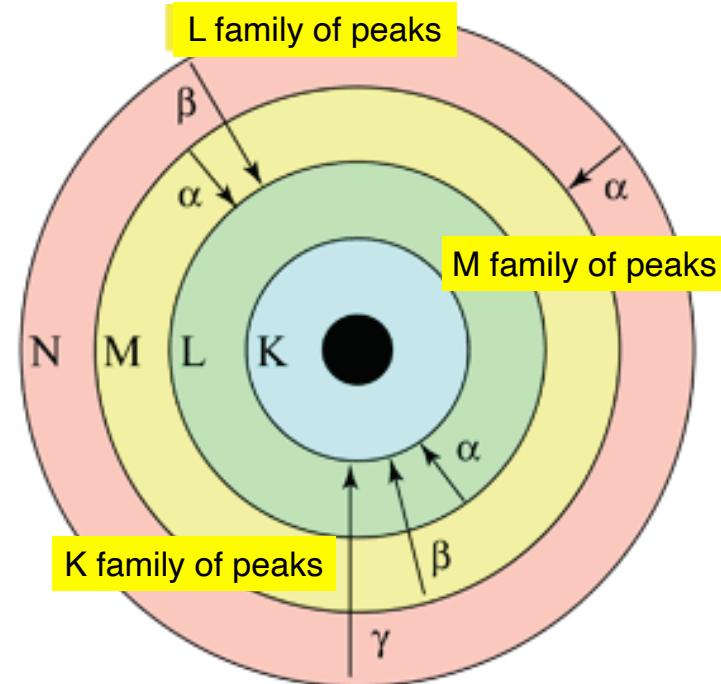
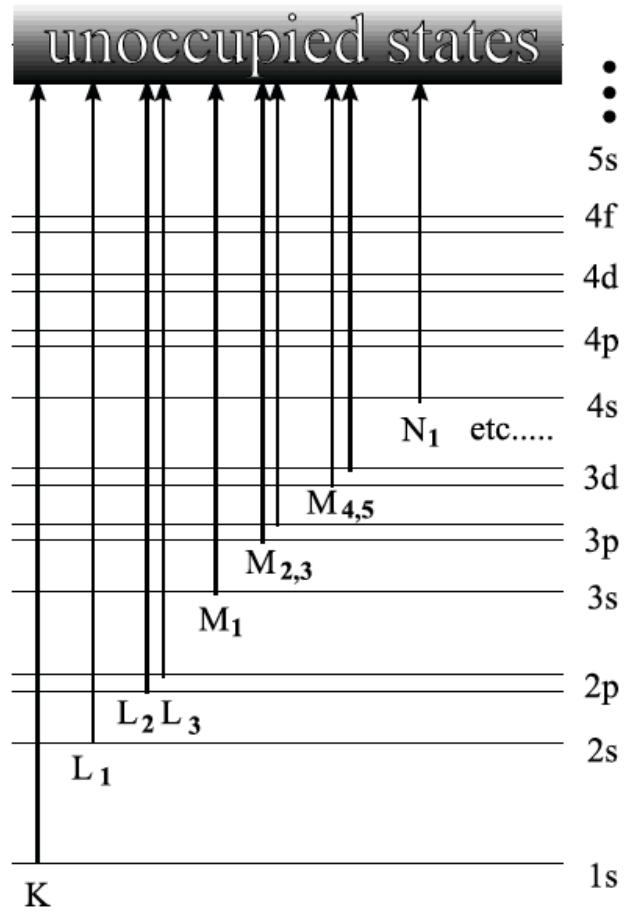
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EPFL A way to probe chemistry



EPFL Edges and peaks nomenclature



EPFL Quiz

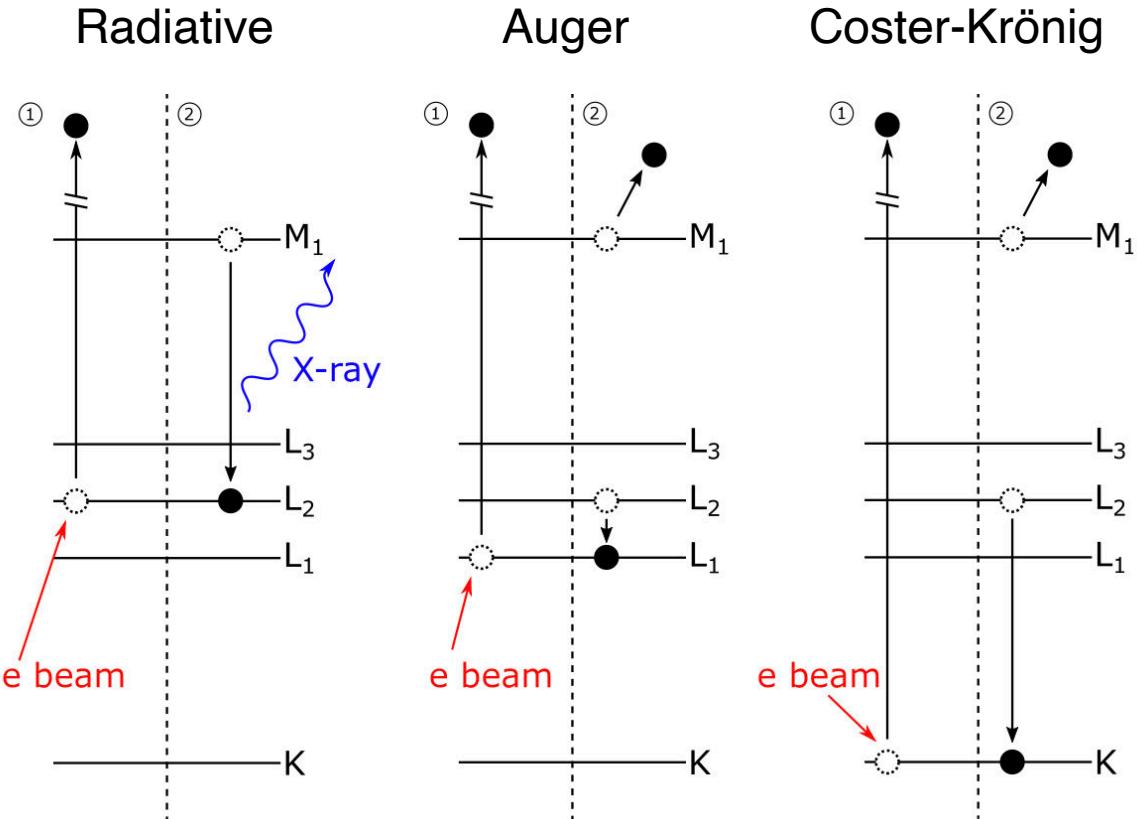
- EDXS: energy dispersive X-ray spectroscopy
⇒ intensity spectrum of X-ray peaks separated by energy
- EELS: electron energy-loss spectroscopy
⇒ intensity spectrum of energy lost by transmitting e^-
- We look at a sample containing Oxygen. We detect the Oxygen K-edge both in EELS and in EDXS. We find the transition at E_{EELS} in EELS and E_{EDXS} in EDXS
- Do we have:
 - 1) $E_{\text{EELS}} > E_{\text{EDXS}}$
 - 2) $E_{\text{EELS}} = E_{\text{EDXS}}$
 - 3) $E_{\text{EELS}} < E_{\text{EDXS}}$

EPFL Contents

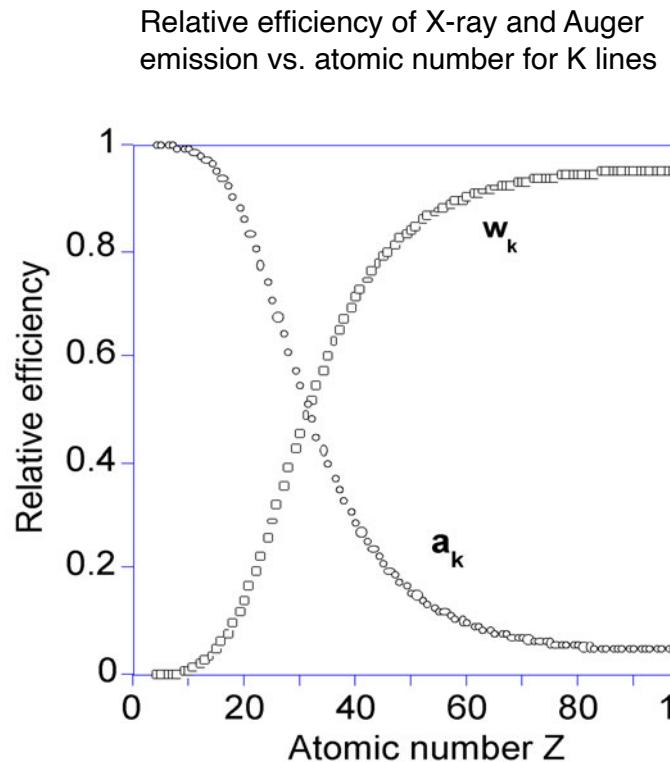
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EPFL X-ray generation

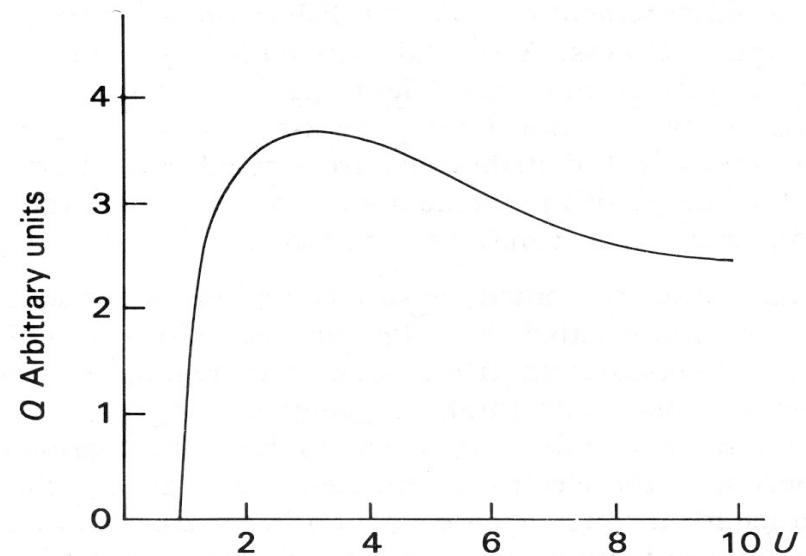
- 3 basic de-excitation process:
 - Radiative X-ray emission
 - Auger transitions/emission
 - Coster-Krönig transitions
- Complex “cascade” effects possible



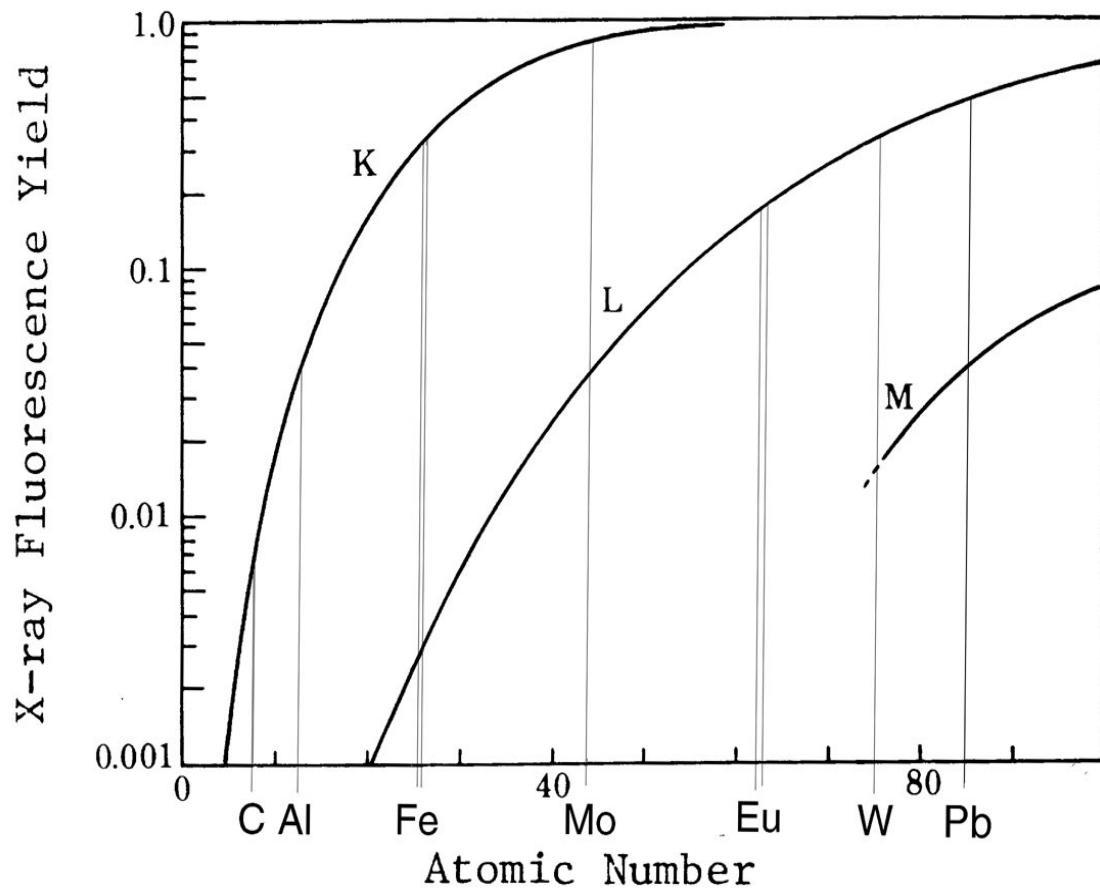
EPFL X-ray generation



Light element atoms return to fundamental state mainly by Auger emission. For that reason, their K-lines are weak. In addition their low energy makes them easily absorbed.

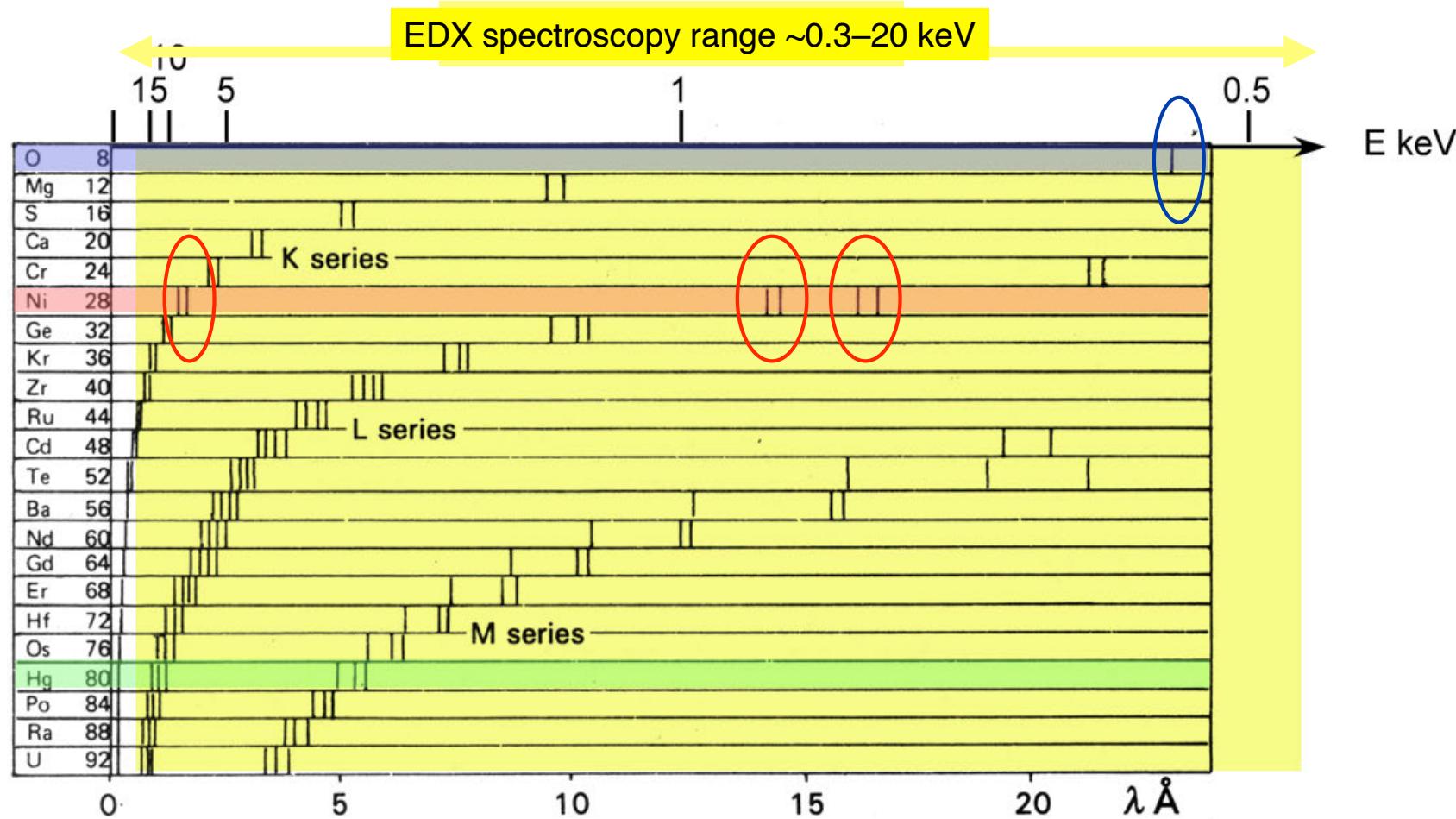


To ionise an atom, the incident electron MUST have an energy larger than the core shell level $U>1$. To be efficient, it should have about twice the edge energy $U>2$.

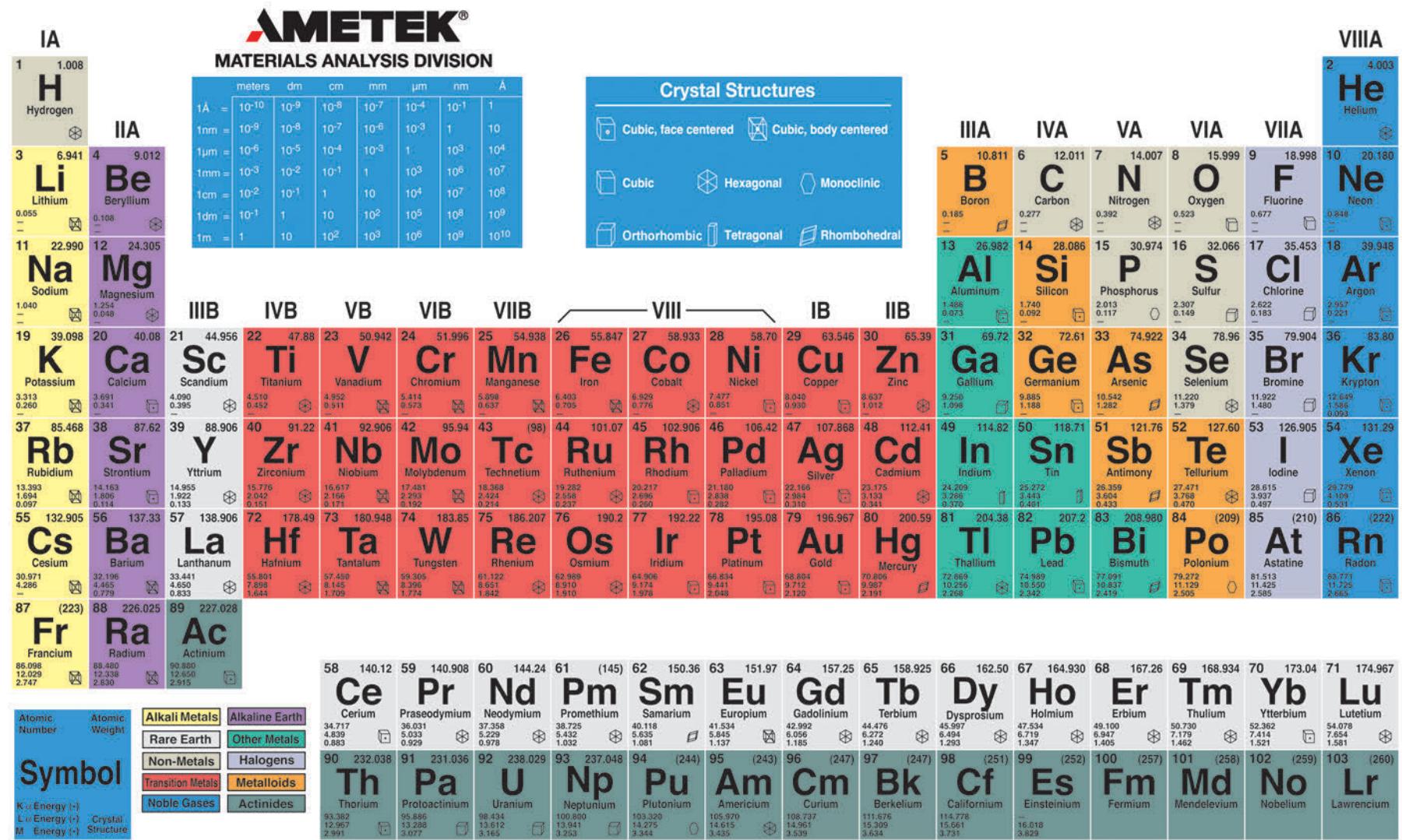


X-ray fluorescence yield for *K*-, *L*-, and *M*-shells, as a function of atomic number.

EPFL Separation of EDX peaks



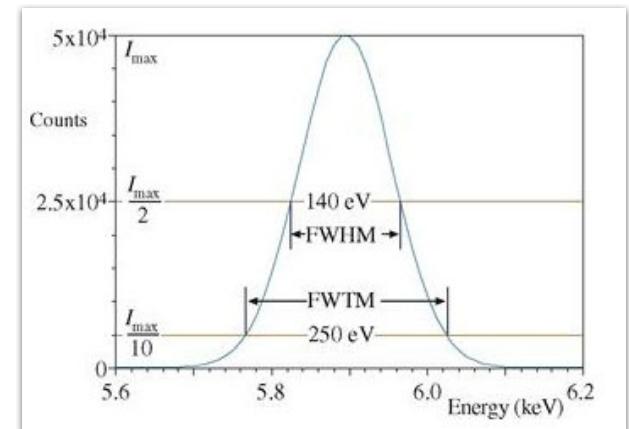
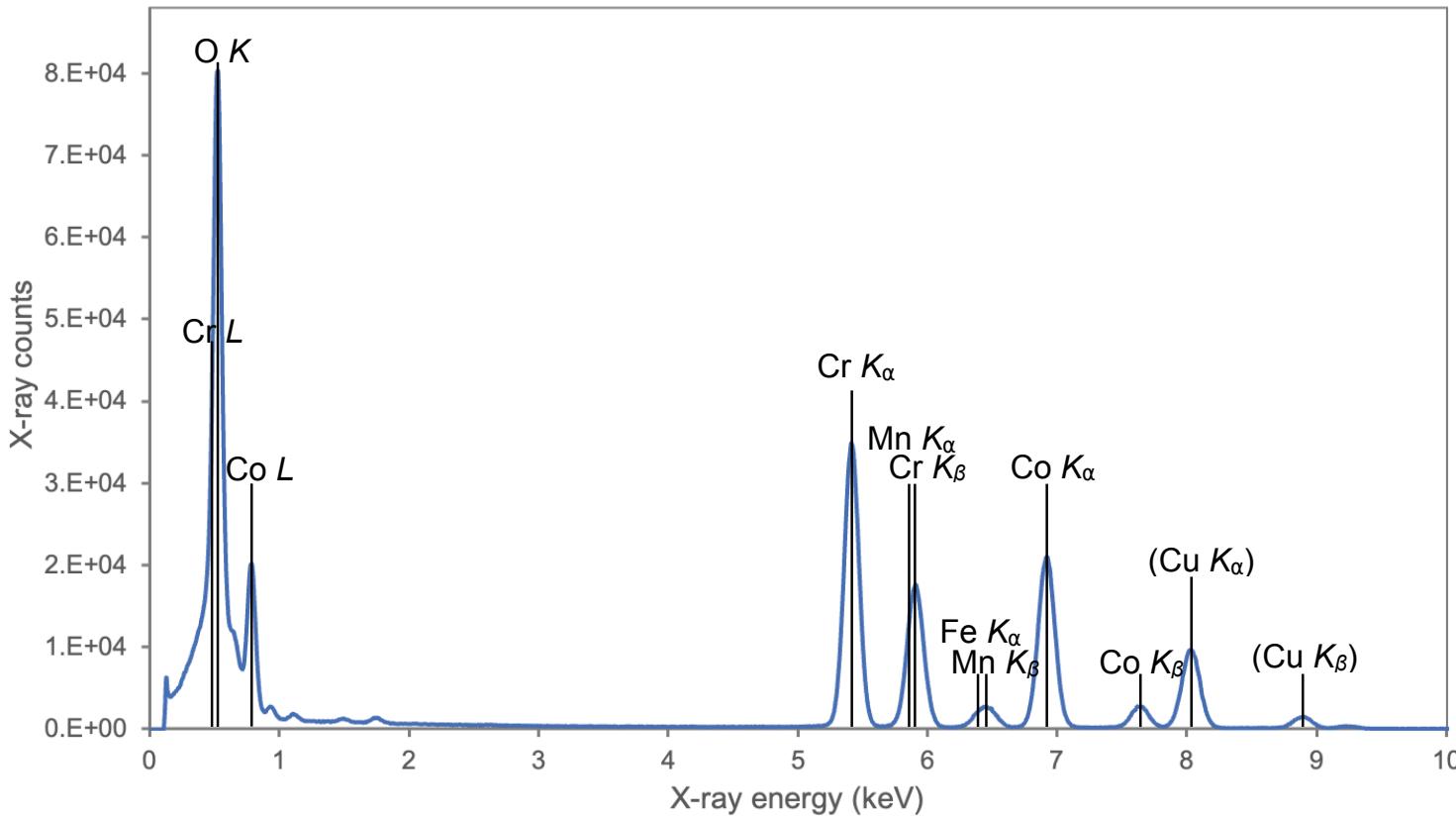
EPFL Periodic table of X-ray peaks



		IIIA		IVA		VA		VIA		VIIA		0	
5	10.811	6	12.011	7	14.007	8	15.999	9	18.998	10	20.180		2
	B		C		N		O		F	Ne		He	4.003
	Boron		Carbon		Nitrogen		Oxygen		Fluorine	Neon		Helium	
0.185		0.277		0.392		0.523		0.677		0.848			
—		—		—		—		—		—			
13	26.982	14	28.086	15	30.974	16	32.066	17	35.453	18	39.948		
	Al		Si		P		S		Cl	Ar			
	Aluminum		Silicon		Phosphorus		Sulfur		Chlorine	Argon			
1.486		1.740		2.013		2.307		2.622		2.957			
0.073		0.092		0.117		0.149		0.183		0.221			
—		—		—		—		—		—			
31	69.72	32	72.61	33	74.922	34	78.96	35	79.904	36	83.80		
	Ga		Ge		As		Se		Br	Kr			
	Gallium		Germanium		Arsenic		Selenium		Bromine	Krypton			
9.250		9.885		10.542		11.220		11.922		12.649			
1.098		1.188		1.282		1.379		1.480		1.586			
—		—		—		—		—		0.093			
49	114.82	50	118.71	51	121.76	52	127.60	53	126.905	54	131.29		
	In		Sn		Sb		Te		I	Xe			
	Indium		Tin		Antimony		Tellurium		Iodine	Xenon			
24.209		25.272		26.359		27.471		28.615		29.779			
3.286		3.443		3.604		3.768		3.937		4.109			
0.370		0.401		0.433		0.470		0.497		0.531			

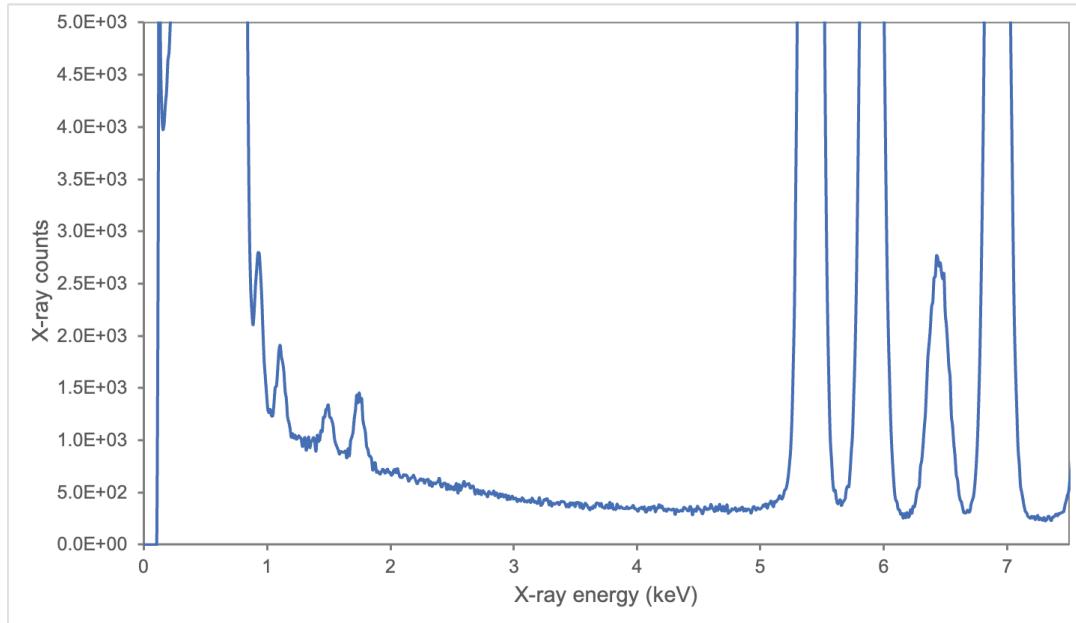
EPFL The EDX spectrum

- Example spectrum from fuel cell sample containing O, Cr, Mn, Fe, Co
- Spectrum of mostly well-defined peaks that e.g. can be fitted with Gaussians



EPFL Bremsstrahlung background

- Continuum background of radiation emitted when e^- velocity changed by atomic field
- Stronger at low keV; depends on atomic number Z



“State-of-the-art” model by Chapman (down to 1 keV): $I_{\text{brem}} = \frac{\beta_0}{E_{\text{X-ray}}} + \beta_1 + \beta_2 E_{\text{X-ray}}$

EPFL EDXS quantification

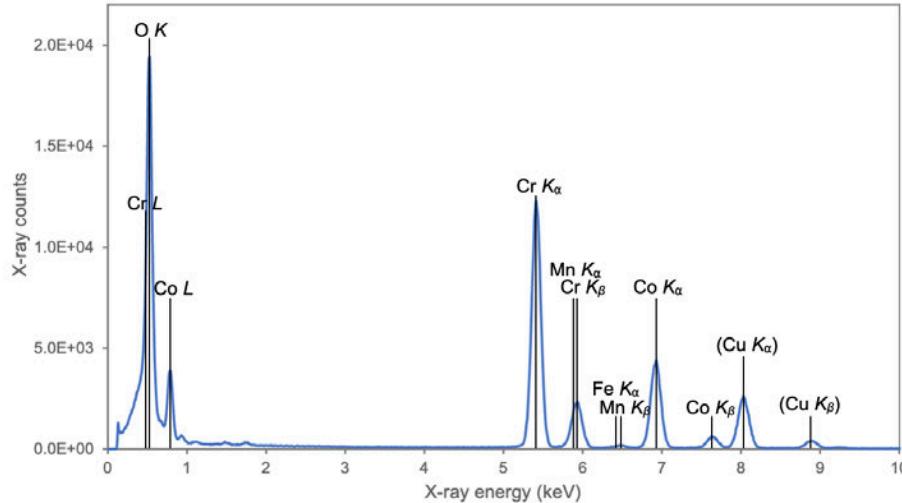
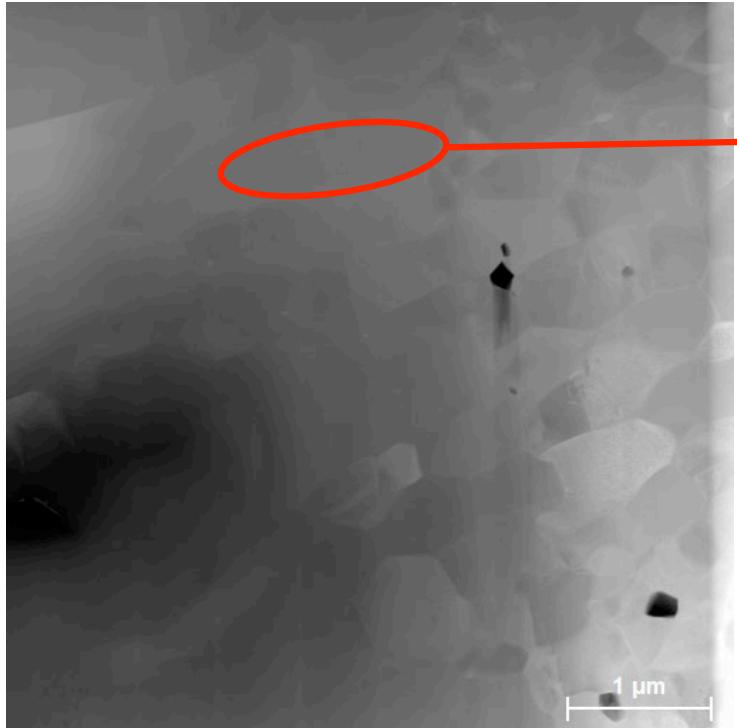
- To go from qualitative to quantitative: measure the intensities I_j of the X-ray peaks (area under the peak)
- Typically apply “Cliff-Lorimer” approach where calculate ratios of constituent elements:

$$\frac{C_A}{C_B} = k_{AB} \frac{I_A}{I_B}$$

- k_{AB} : k -factor
 - determined empirically by: standards / theoretical calculations / empirical models
- k -factors relate to probability of X-ray emission, probability of X-ray absorption and probability of unabsorbed X-ray being detected
- Rule of thumb: quantification accuracy 10–20%. However, much better (e.g. 1%) can be achieved in certain cases
- Detection limit: ~0.1 – a few at. %

EPFL EDXS quantification

- Example: Cr-rich grain in fuel cell spinel layer



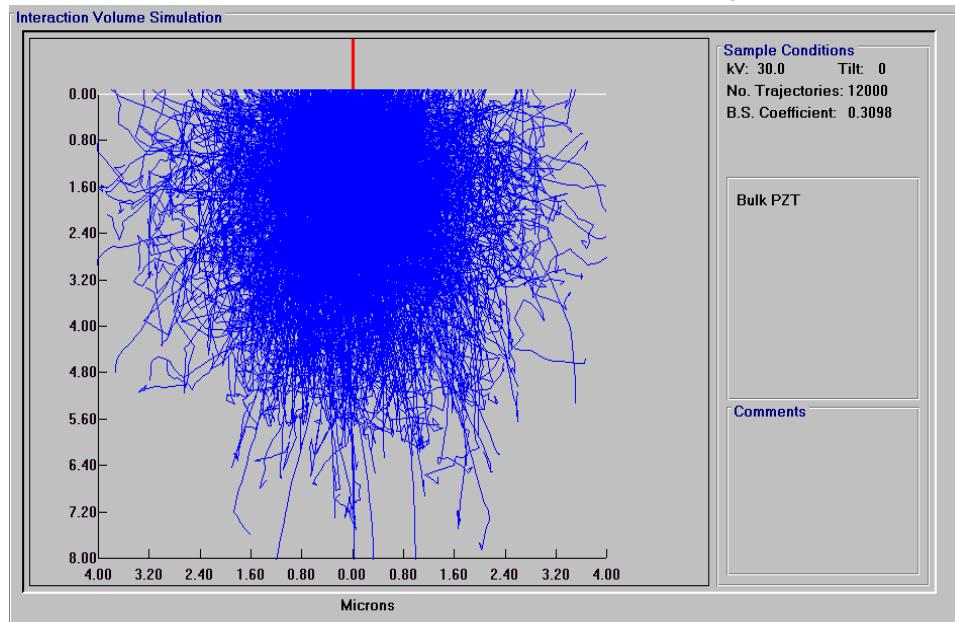
Element	Peak series	At. %
Cr	K	33.7
Co	K	13.8
Mn	K	2.5
Fe	K	0.1
O	K	49.9

EPFL Compared to SEM-EDXS

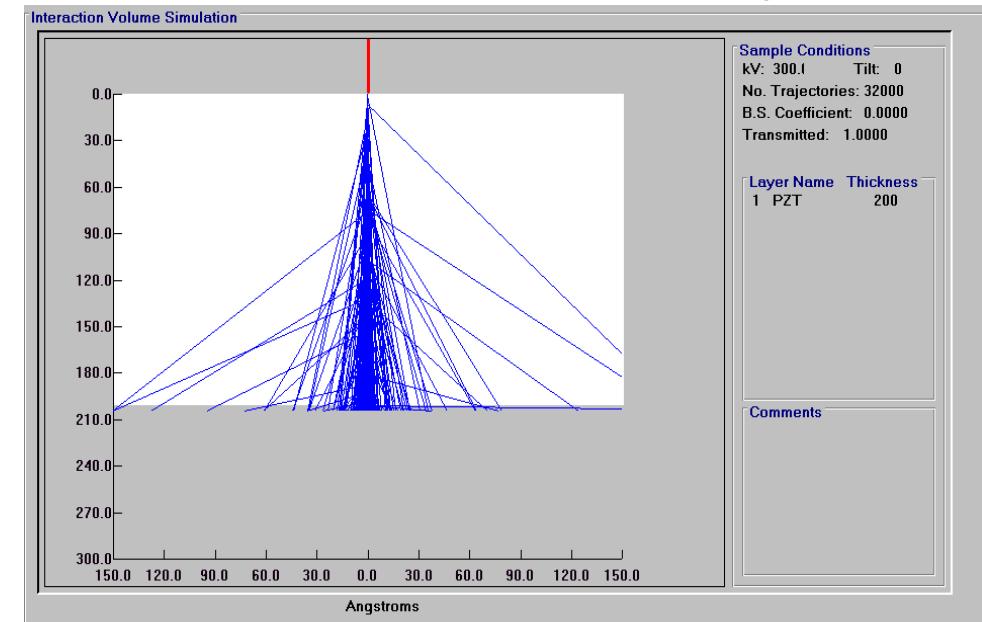
- (Can) Neglect correction factors for absorption and fluorescence in quantification
- High energy e-beam and thin sample \Rightarrow X-rays emitted from narrow/confined volume of sample in beam path direction

Pb(Zr,Ti)O₃ scattering models

SEM: 30 keV beam, bulk sample

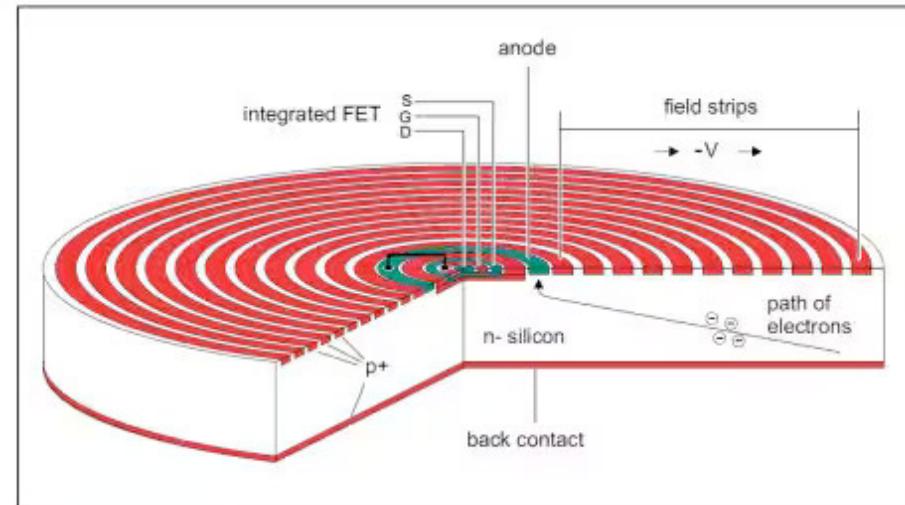


STEM: 300 keV beam, thin sample



EPFL EDX detection

- Modern standard is the *Silicon Drift Detector (SDD)*
- Incident X-ray absorbed in Si creates e^- - h^+ pairs
- Internal electric field drifts e^- charge towards anode
- Accumulated charge converted to voltage by a pre-amplifier
- Quantity of charge carriers depends on X-ray energy
⇒ measured voltage corresponds to energy of detected X-ray

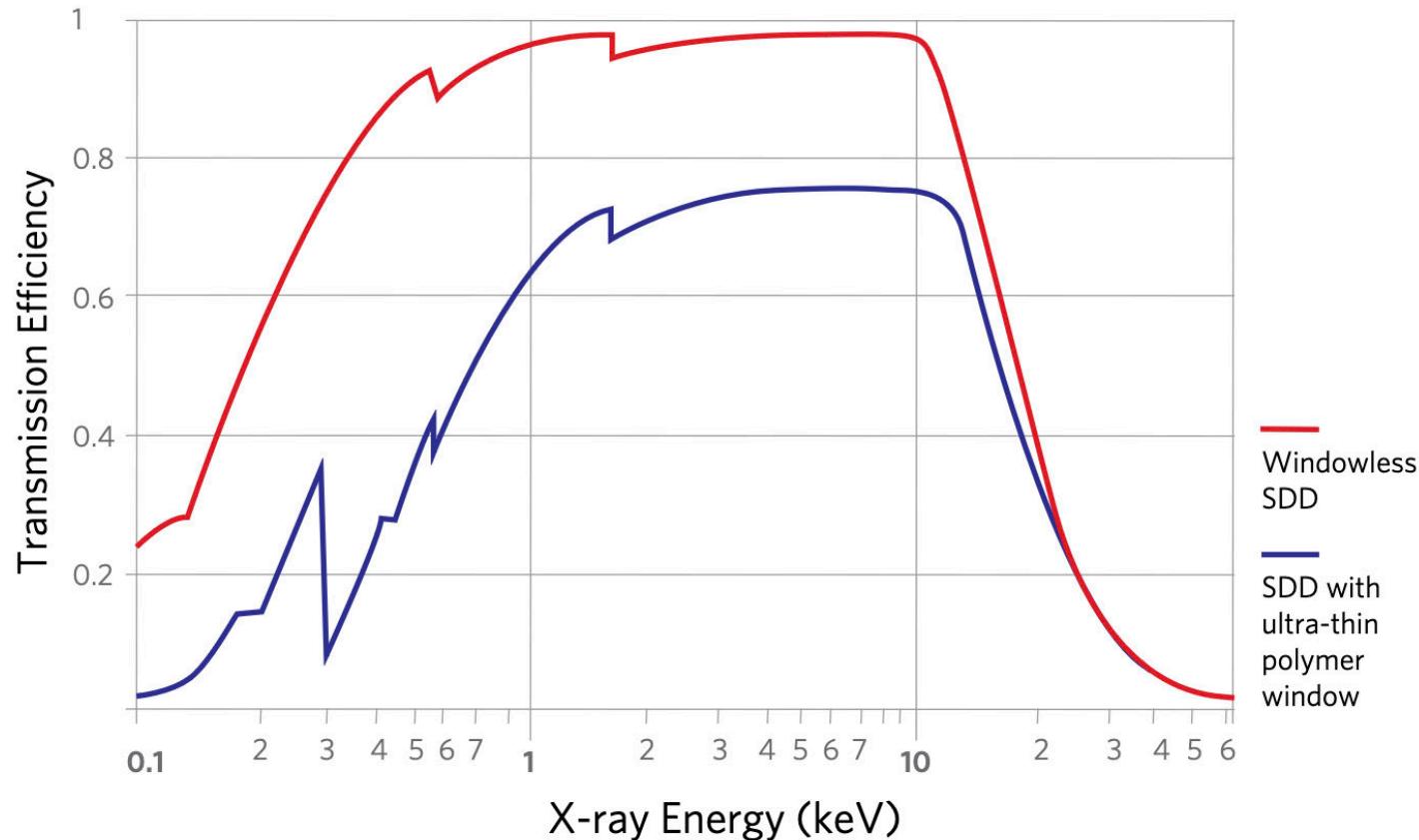


Example SDD detector design

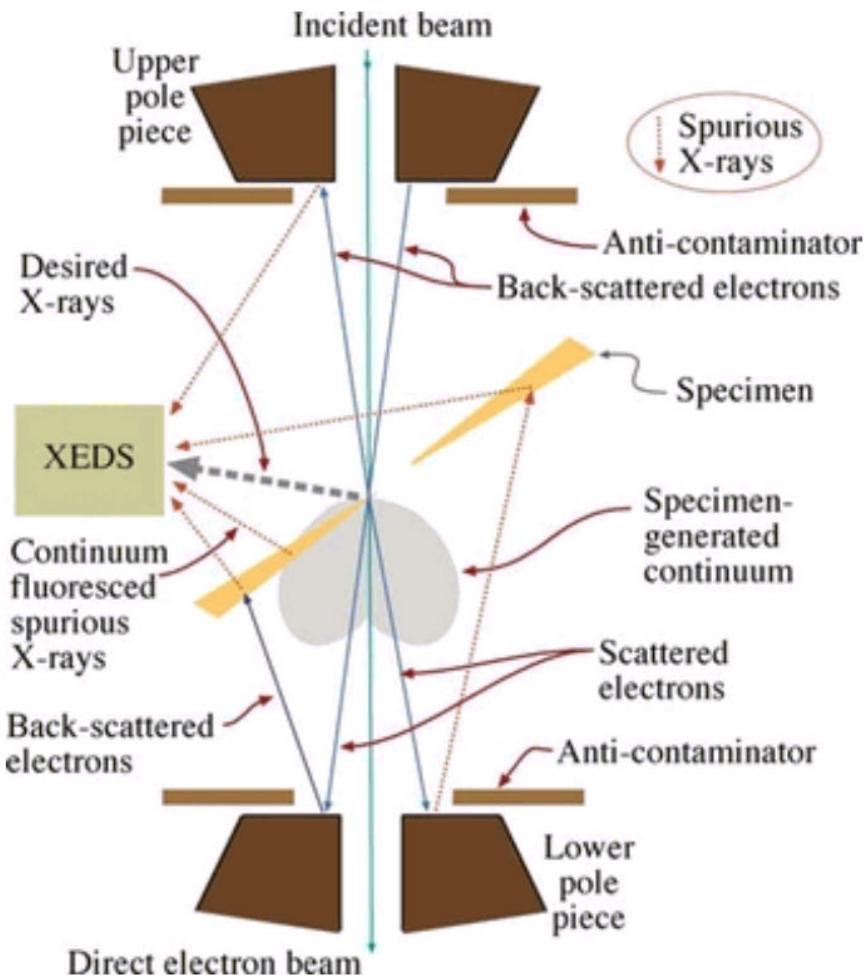


EPFL Detective quantum efficiency (DQE)

- SDD detectors are compact and fast, but poor DQE for X-rays $\gtrsim 20$ keV



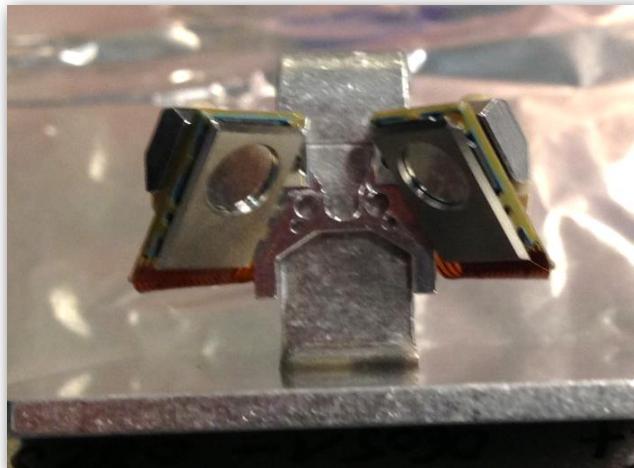
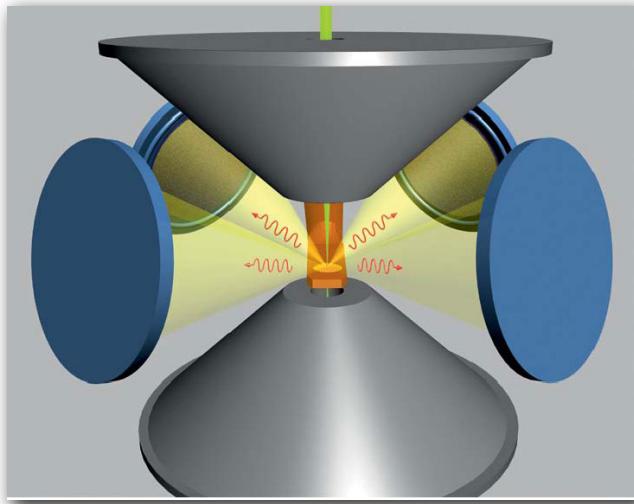
EPFL Detection geometry



- Take care of spurious artefact X-ray peaks

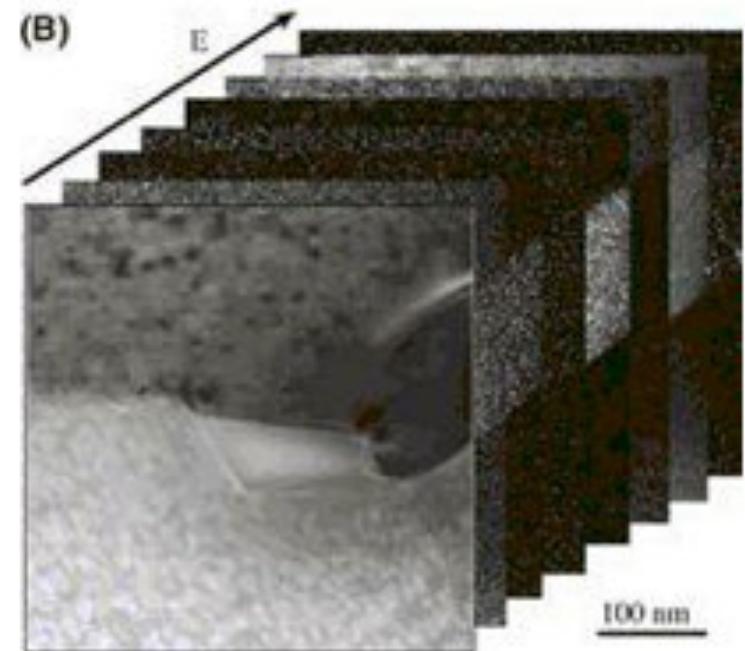
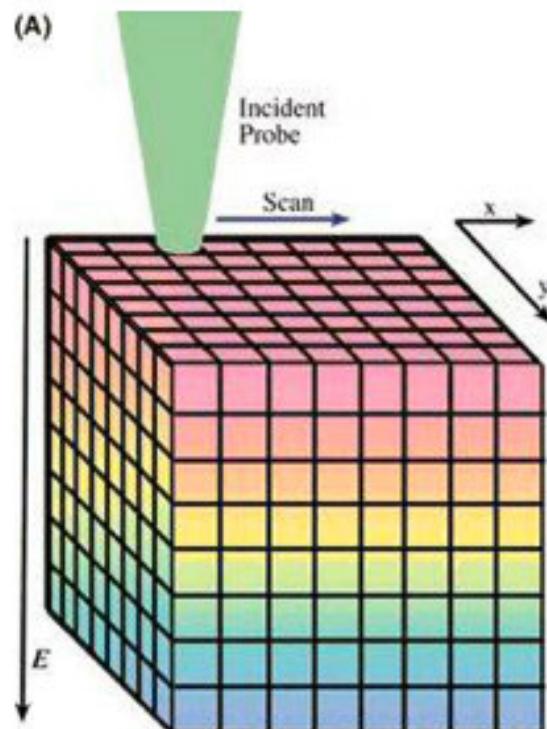
EPFL Detection geometry

- New standard is to use multiple SDDs to increase solid angle of collection and hence detection efficiency
- For example: “Super-X” on Osiris, Titan with 4 quadrants giving ~ 1 Sr solid angle of collection
- State-of-the-art: Thermo Fisher Scientific Ultra with ~ 4 Sr



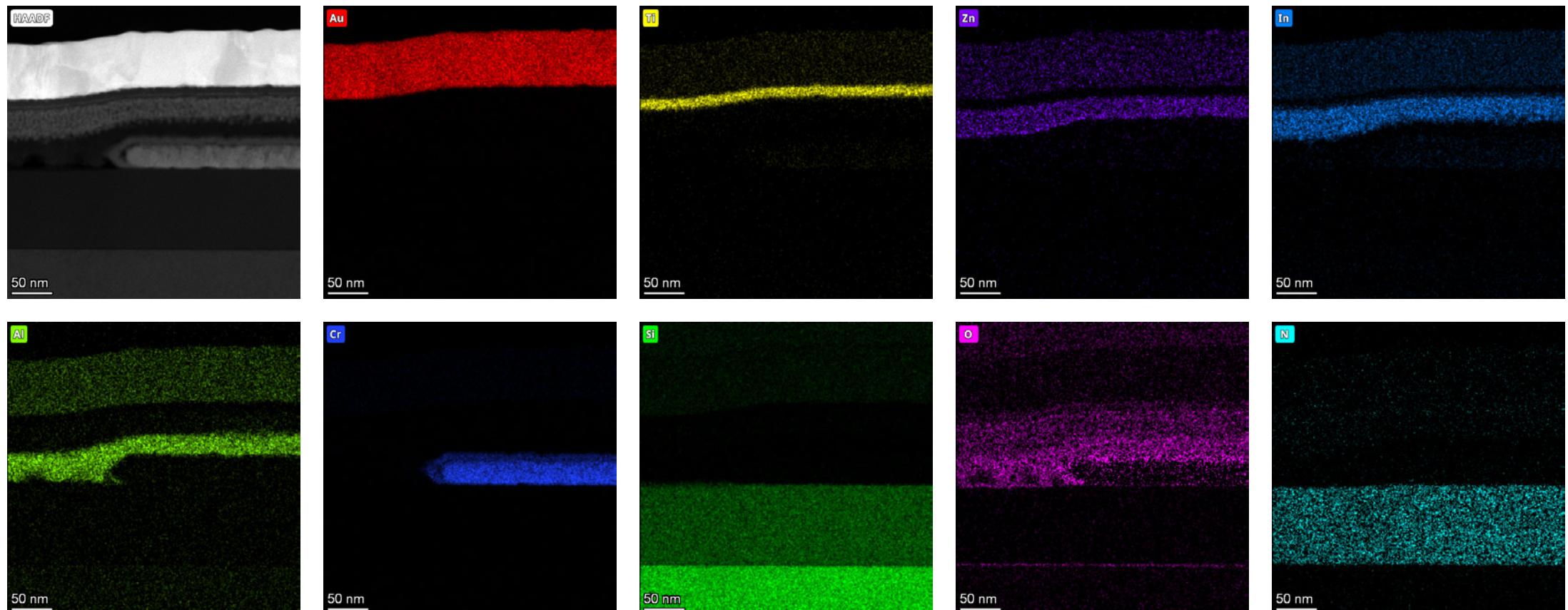
EPFL STEM-EDXS data-cube

- EDXS map: acquire one spectrum per pixel position (x, y)
- Gives 3D data-cube of information with axes (x, y, E)
- Data can be post-processed – integrate area under peak to generate qualitative elemental map



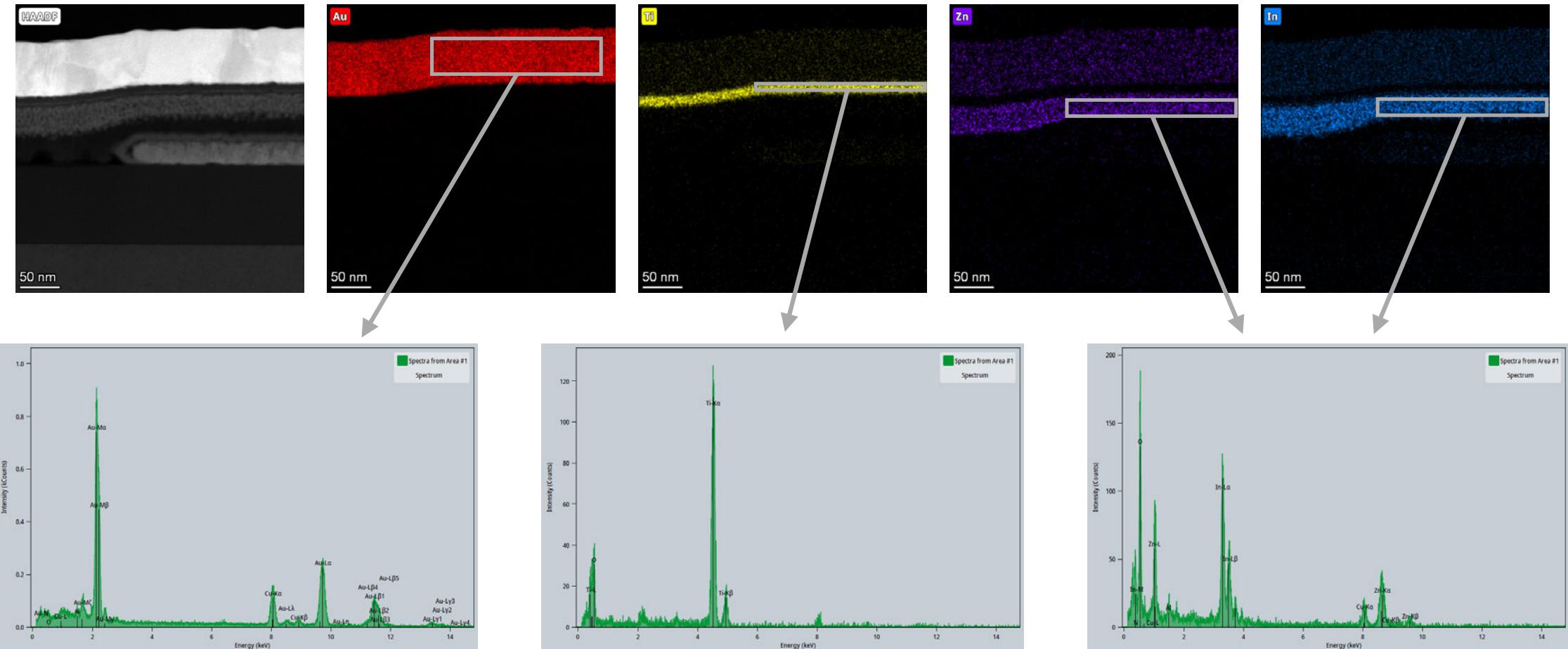
EPFL EDXS mapping: applications

- Multilayer sample – *net counts* maps



EPFL EDXS mapping: applications

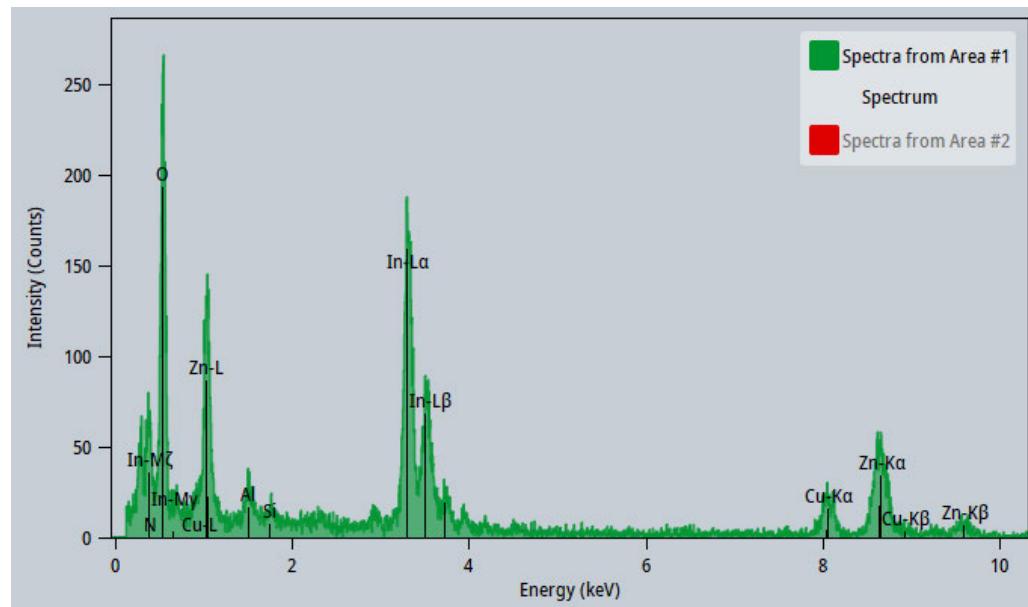
- Multilayer sample – *integrated counts* EDX spectra



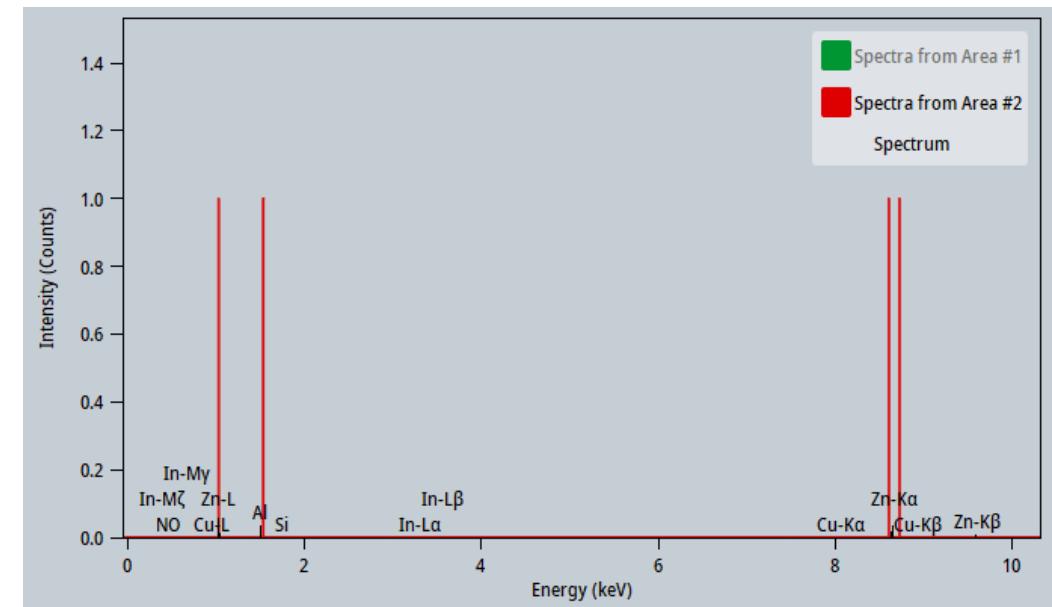
EPFL Why integrate counts across spatial ROI?

- In-Zn-O layer:

Integrated from $270 \times 25 = 6'750 \text{ px}^2$

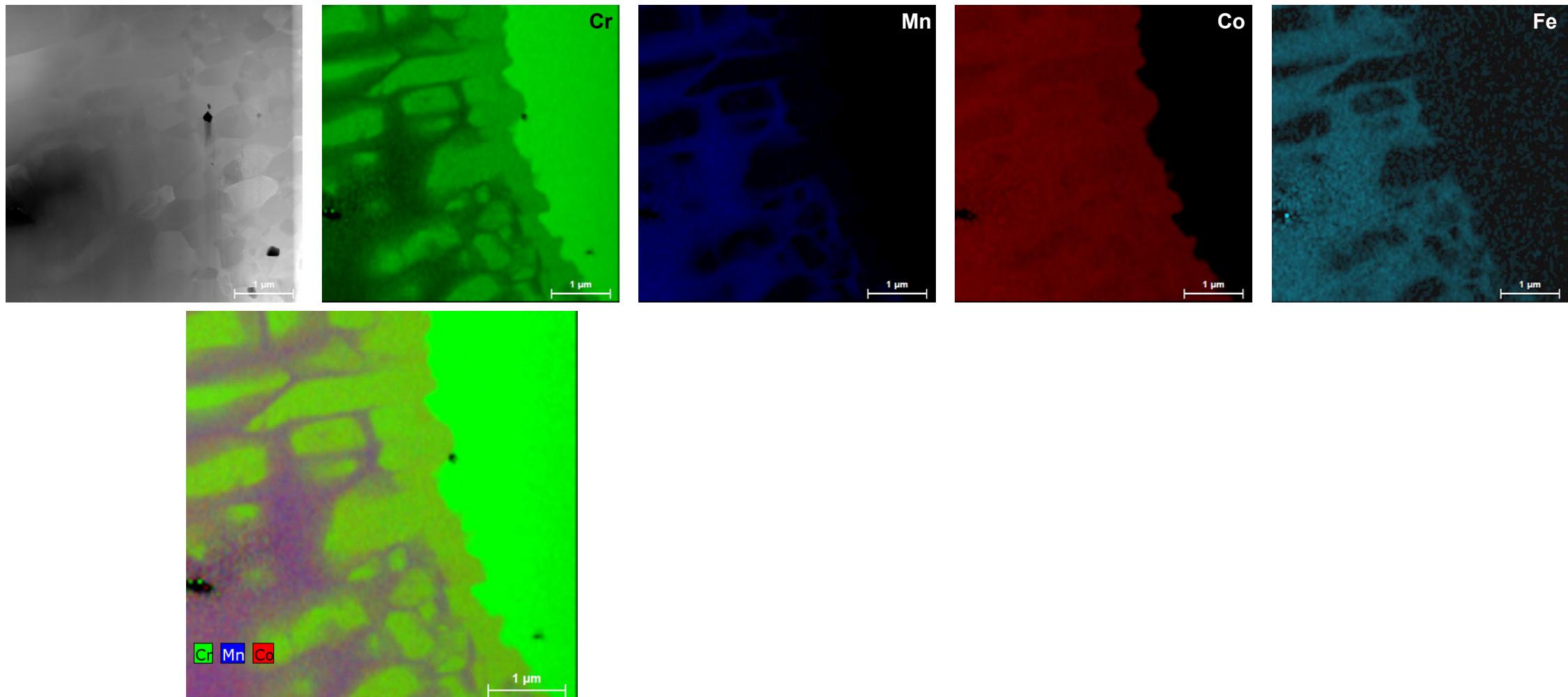


Single pixel spectrum



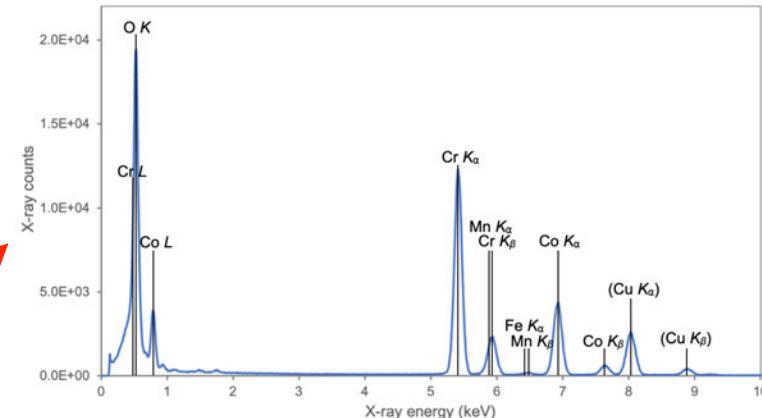
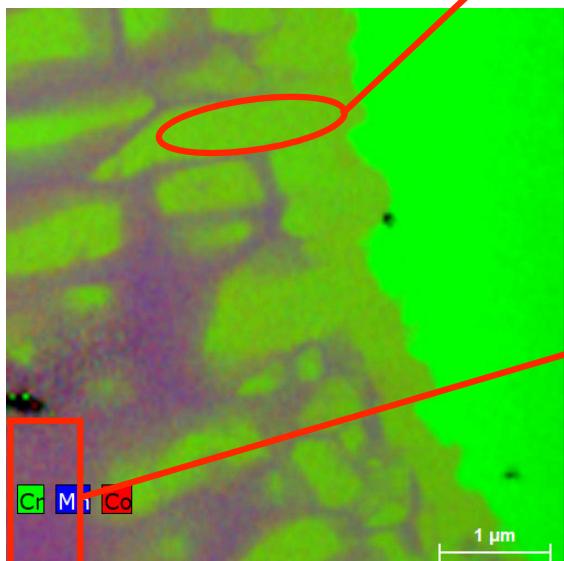
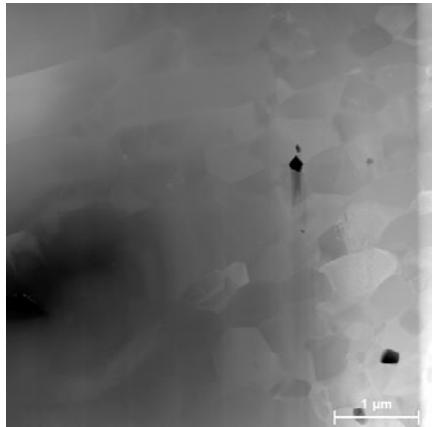
EPFL EDXS mapping: applications

- Fuel cell sample: Fe-doped MnCo₂O₄ spinel layer

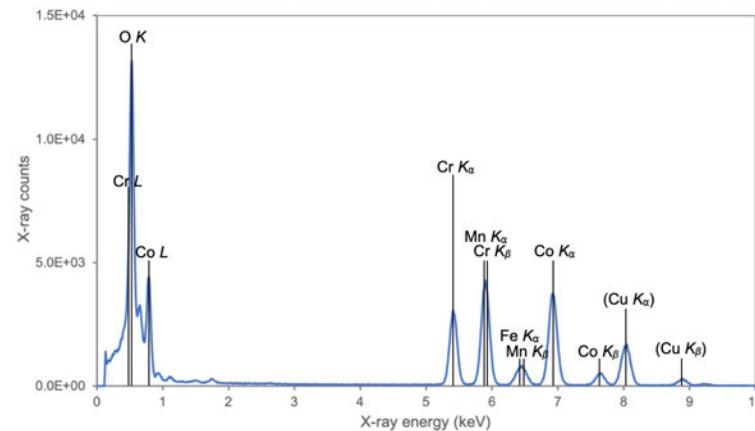


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Co	K	13.8
Mn	K	2.5
Fe	K	0.1
O	K	49.9



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Cr	K	12.5
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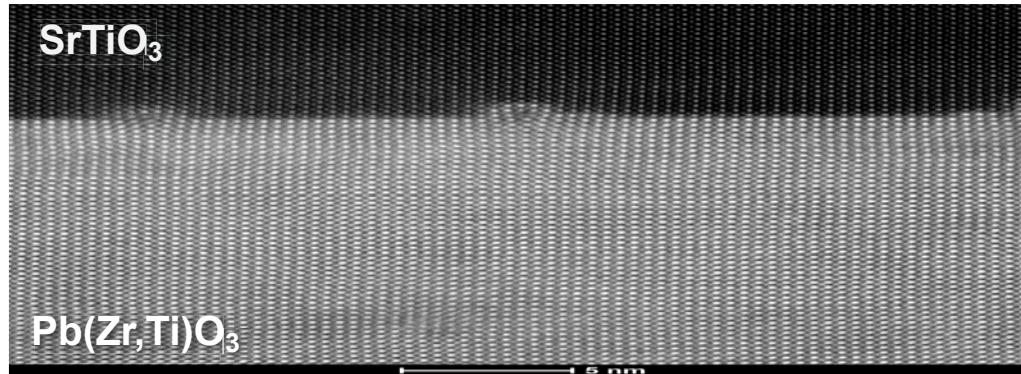
EPFL Atomic resolution EDXS with Cs-STEM

- Sample of $\text{Pb}(\text{Zr},\text{Ti})\text{O}_3$ on SrTiO_3



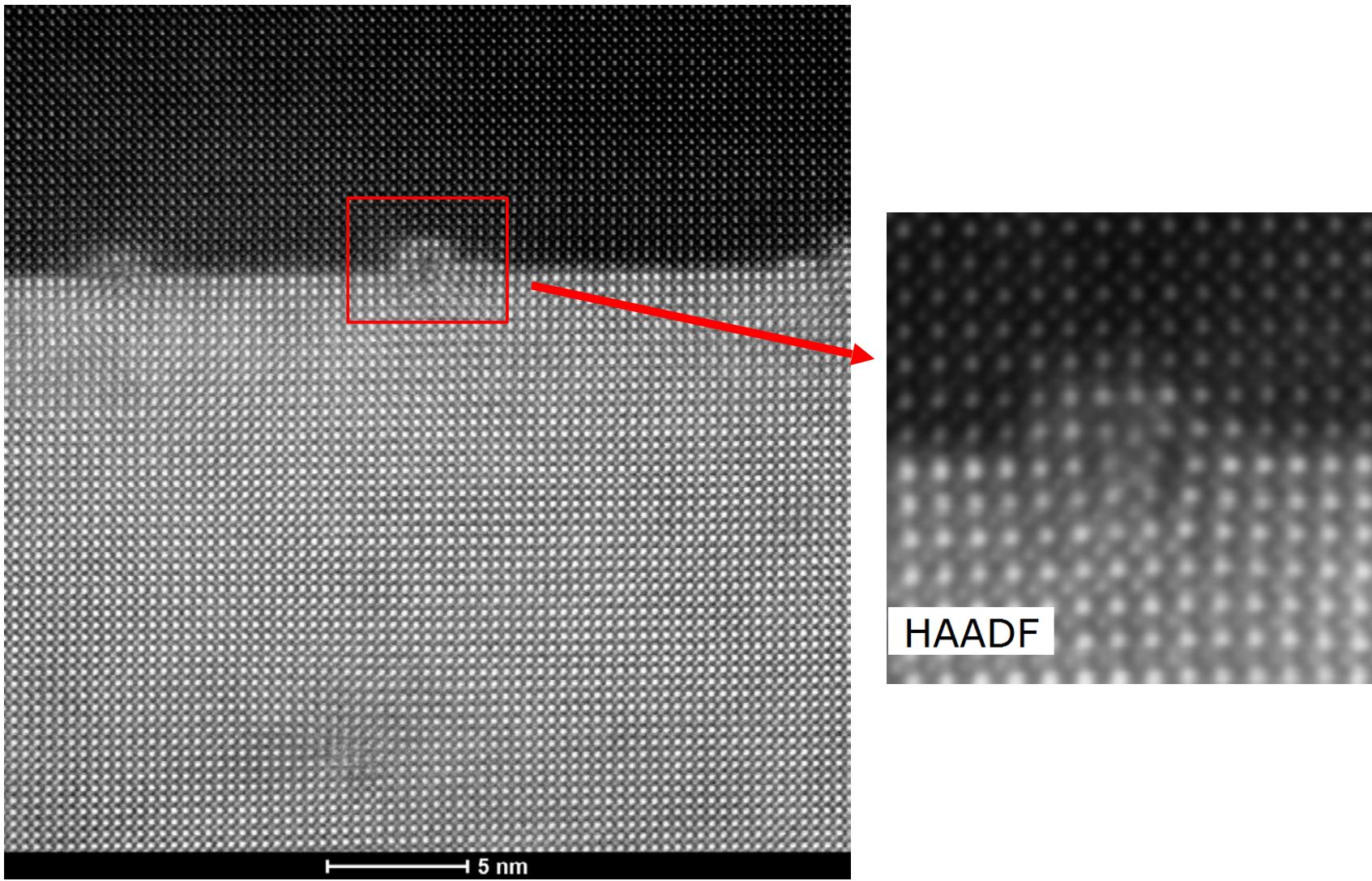
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EPFL Atomic resolution EDXS with Cs-STEM

- Sample of $\text{Pb}(\text{Zr},\text{Ti})\text{O}_3$ on SrTiO_3



EPFL Atomic resolution EDXS with Cs-STEM

- Sample of $\text{Pb}(\text{Zr},\text{Ti})\text{O}_3$ on SrTiO_3 – atomic resolution elemental mapping

